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7		3	5	8	7	4	3	5	Jun. 28, 1971	Chioffe		95	89	
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7		3	9	5	9	0	4	8	May 25, 1976	Stanfield et al.		156	94	
9		4	0	2	6	7	5	6	May 31, 1977	Stanfield et al.		156	554	
4		4	0	8	1	5	7	7	Mar. 28, 1978	Homer		427	424	
4		4	1	4	2	1	0	7	Feb. 27, 1979	Hatzakis et al.		250	571	
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0		Kesoli	ution	Care	diac In	nages	", Do	yle,	M., et al., 8306 M	agnetic Resonance	in Med	icine 31, No	o. 5,	
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D										Noise Reduction a EEE, pp. 335-338, I		ge Enhance	ment",	
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0		"Gray	scal	e Cho	racte	ristics	", Th	e Na	ture of Color Ima	ges, Photographic N	egative	es, pp. 163-	168.	
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RECEIVED JUN 1 2 2002 JUN 1 0 2002 **PTO FORM 4/92** ATTY. ASESSI16-PA-US TECHNOLOGY Center 26 09/960,239 **FORM PTO-1449** LIST OF PATENTS AND PUBLICATIONS APPLICANT Albert D. Edgar Sept. 21, 2001 FOR APPLICANT'S INFORMATION GROUP FILING DATE DISCLOSURE STATEMENT FOR: Method And System For Improving Scanned Image Detail UNITED STATES LETTERS PATENT **DOCUMENT NUMBER** NAME CLASS DATE SUB CLASS 4 5 4 0 Jan. 14, 1986 Fukuda 354 317 6 4 5 9 4 5 9 8 Jun. 10, 1986 Iwagami 346 140 2 0 Nov. 4, 1986 4 6 1 3 7 30 Kanda et al. 430 4 6 2 3 2 3 6 Nov. 18, 1986 Stella 354 318 4 6 3 6 8 0 8 Jan. 13, 1987 Herron 346 75 3 May 19, 1987 4 6 6 Matsumoto et al. 356 6 0 404 7 7 4 6 0 7 9 Jun 2, 1987 Nagano 358 75 4 2 2 7 3 6 1 Apr. 5, 1988 Shidara 354 317 4 7 4 5 0 4 0 May 17, 1988 Levine 430 21 4 7 5 5 8 4 4 Jul. 5, 1988 Tsuchiya et al. 354 317 4 7 7 7 1 2 0 Levine 430 Oct. 11, 1988 21 4 7 9 6 0 6 I Jan. 3, 1989 Ikeda et al. 355 73 4 8 1 4 6 3 0 Mar. 21, 1989 250 Lim 578 4 8 2 Apr. 11, 1989 1 1 1 4 Gebhardt 358 75 4 4 5 8 5 5 Jul. 4, 1989 Matsumoto 358 80 5 4 3 8 1 1 1 Jul. 25, 1989 Millis et al. 430 30 4 8 5 7 4 0 Millis et al. 3 Aug. 15, 1989 430 30 4 7 0 8 5 6 7 Oct. 17, 1989 Kanzaki et al. 354 325 4 9 5 Nov. 6, 1990 9 6 0 Haruki et al. 358 228 FOREIGN PATENT DOCUMENTS DOCUMENT NUMBER DATE COUNTRY CLASS SUB **CLASS** WO 98/34397 < Aug. 6, 1998 **PCT** H04N WO 99/43148 Aug. 26, 1999 **PCT** H04N 1/00 WO 01/01197 / Jan. 4, 2001 PCT G03D 5/00 WO 01/13174 A1 Feb. 22, 2001 PCT G03D 5/06 EP 0 261 782 A2 / Aug. 14, 1987 Europe H04N 1/46 EP 0 422 220 A1 Mar. 28, 1989 Europe A61B 6/03 EP 0 482 790 B1/ Sep. 9, 1991 Еигоре H04N 1/40 EP 0 525 886 A3 1 Jul. 21, 1992 Europe **G03D** 5/00 EP 0 580 293 A1 Jun. 22, 1993 Europe H04N 1/04 EP 0 669 753 A2/ Feb. 24, 1995 H04N Europe 1/407 OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.) "Protorealistic Ink-Jet Printing Through Dynamic Spot Size Control", Wallace, D., Journal of Imaging Science and Technology, Vol. 40, No. 5, pp. 390-395, Sept/Oct. 1996. "MicroJet Printing of Solder and Polymers for Multi-Chip Modules and Chip-Scale Package", Hayes, D., et al., MicroFab Technologies, Inc. "A Method of Characterisstics Model of a Drop-on-Demand Ink-Jet Device Using an Integral Method Drop Formation Model", Wallace, D., MicroFab Technologies, Inc., The American Society of Mechanical Engineers, Winter Annual Meeting, pp. 1-9, Dec. 10-15, 1989. "Digital Imaging Equipment White Papers", Putting Damaged Film on ICE, www.nikonusa.com/reference/whitepapers/imaging, Nikon Corporation, Nov. 28, 2000.

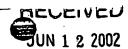
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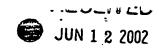
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9	d	5	1	0	1	2	8	6	Mar. 31, 1992	Patton		358	487
	9	5	1	2	4	2	1	6	Jun. 23, 1992	Giapis et al.		430	30
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~	4	5	1	9	6	2	8	5	Mar. 23, 1993	Thomson		430	30
4	1	5	2	1	2	5	1	2	May 18, 1993	Shiota		354	319
~	U	5	2	3	5	4	3	9	Jul. 27, 1993	Takahashi et al.		354	313
9	1	5	2	3	5	3	5	2	Aug. 10, 1993	Pies et al.		346	140
2	4_	5	2	6	6	8	0	5	Oct. 26, 1993	Blackman		15	308
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7	4	5	3	5	0	6	6	4	Sep. 27, 1994	Simons		430	362
4		5	3	5	7	3	0	7	Oct. 18, 1994	Glanville et al.		354	324
		5	3	6	0	7	0	1	Nov. 1, 1994	Elton et al.		430	501
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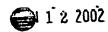
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-4		5	4	3	6	7	3	8	Jul. 25, 1995	Manico		358	293 503
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7	9	5	5	1	9	5	1	0	May 21, 1996	Edgar		358	471
Q	"	5	5	5	2	9	0	4	Sep. 3, 1996	Ryoo et al.		358	518
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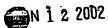
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		5	5	8	1	3	7	6	Dec. 3, 1996	Harrington	358	518
	1/2	5	5	9	6	4	1	5	Jan. 21, 1997	Cosgrove et al.	358	296
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Technology Center 2600 Page 7 of 7 **PTO FORM 4/92** SERIAL NO. 09/960,239 ASF00116-PA-US **FORM PTO-1449** AADEHARK **IDOCKET** Albert D. Edgar LIST OF PATENTS AND PUBLICATIONS APPLICANT FILING DATE | Sept. 21, 2001 GROUP FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT FOR: Method And System For Improving Scanned Image Detail UNITED STATES LETTERS PATENT DOCUMENT NUMBER NAME CLASS SUB DATE **CLASS** Sep. 3, 1974 Krumbein 226 92 3 8 3 6 2 5 5 Slaker 356 431 4 6 5 4 May 5, 1981 4 3 3 ō 0 Dec. 30, 1986 Sakai 358 41 6 3 7 2 May 3, 1988 Taft et al. 356 376 4 4 1 6 1 5 7 354 299 0 4 Jun. 25, 1991 Manico et al. 1 6 5 2 0 0 8 1 7 Apr. 6, 1993 Birnbaum 358 80 5 3 3 2 4 7 Aug. 2, 1994 Columbus et al. 118 411 4 D 5 7 3 4 5 Dec. 19, 1995 358 500 4 Tse 5 5 8 7 7 5 2 Dec. 24, 1996 Petruchik 396 315 5 7 0 Manico 430 434 6 2 I 6 May 6, 1997 5 6 4 9 2 6 0 Jul. 15, 1997 Wheeler et al. 396 569 5 396 5 8. 3 7 9 5 Nov. 10, 1998 Craig et al. 6 2 5 9 5 9 7 0 Sep. 28, 1999 Kwon et al. 355 38 6 0 8 8 0 8 4 Jul. 11, 2000 Nishio 355 75 2 7 8 Mar. 13, 2001 Takano et al. 430 362 6 0 0 3 FOREIGN PATENT DOCUMENTS DOCUMENT NUMBER DATE COUNTRY **CLASS SUB CLASS** WO 98/25399 **PCT** 1/38 Jun. 11, 1998 H04N WO 98/34157 1 **PCT** G03D Aug. 6, 1998 WO 99/43149 Aug. 26, 1999 **PCT** H04N 1/100 WO 01/45042 A1 **G06T** 5/00 1 Jun. 21, 2001 PCT WO 01/50192 A1 < Jul. 12, 2001 **PCT** G03C 7/407 WO 01/50193 A1 🖊 Jul. 12, 2001 **PCT** G03C 7/407 0 WO 01/50194 A1 🖊 Jul. 12, 2001 **PCT** G03C 7/407 W0 01/50197 A1 / Jul. 12, 2001 **PCT** G03C 7/42 WO 01/52556 A2 < Jul. 19, 2001 **PCT** H04N 9/11 EP 0 580 293 A1 / Jan. 26, 1994 Europe H04N 1/04 EP 0 601 364 A1 / Jun. 15, 1994 H04N 1/387 Еигоре EP 0 768 571 A2 / Apr. 16, 1997 **G03D** 13/00 Europe EP 0 806 861 A1 Nov. 12, 1997 H04N 1/00 Europe EP 0 878 777 A2 Nov. 18, 1998 **G06T** 5/40 Europe OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

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